Searcn Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/849,724	TAKIGUCHI ET AL.	
Examiner	Art Unit	

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Huyen X. Vo

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SEARCHED						
Class	Subclass	Date	Examiner			
704	256; 255; 236; 233; 235; 231	6/27/2007	HV			
704	244; 243	6/27/2007	HV			
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INTERFERENCE SEARCHED						
Subclass	Date	Examiner				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search included	6/27/2007	HV .		
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